

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Annie F.
J. W.
1-1504

In re Application of Applicants:

Dat : October 23, 2003

Beaman et al.

Group Art Unit: 2829

Serial No.: 09/251,988

Examiner: J. M. Hollington

Filed: February 17, 1999

Docket No.: YO999-088

For: STRUCTURAL DESIGN AND PROCESSES TO CONTROL PROBE POSITION ACCURACY IN A WAFER TEST PROBE ASSEMBLY

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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AMENDMENT

OCT 23 2003

PETITIONS OFFICE

In response to Office Action dated July 10, 2003, please consider the following:

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OFFICE OF PETITIONS